

#### Description

The AP10N04S uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a

Battery protection or in other Switching application.

#### **General Features**

V<sub>DS</sub> = 40V I<sub>D</sub> =10 A

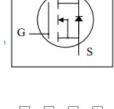
 $R_{DS(ON)}$  < 17m $\Omega$  @  $V_{GS}$ =10V

### **Application**

Battery protection

Load switch

Uninterruptible power supply







# **Package Marking and Ordering Information**

Product ID	Pack	Marking	Qty(PCS)
AP10N04S	SOP-8	AP10N04S XXX YYYY	3000

# **Absolute Maximum Ratings** (T<sub>C</sub>=25°C unless otherwise specified)

Symbol	Parameter	Rating	Units	
Vos	Drain-Source Voltage	40	V	
Vgs	Gate-Source Voltage	Gate-Source Voltage ±20		
I <sub>D</sub> @T <sub>A</sub> =25°C	Continuous Drain Current <sup>1</sup>	Continuous Drain Current <sup>1</sup> 10		
ID@TA=70°C	Continuous Drain Current <sup>1</sup>	Continuous Drain Current <sup>1</sup> 6.7		
Ідм	Pulsed Drain Current <sup>2</sup>	Pulsed Drain Current <sup>2</sup> 50		
EAS	Single Pulse Avalanche Energy <sup>3</sup>	nche Energy <sup>3</sup> 31		
las	Avalanche Current	25		
P <sub>D</sub> @T <sub>A</sub> =25°C	Total Power Dissipation <sup>4</sup>	1.9	W	
Тѕтс	Storage Temperature Range	-55 to 150	°C	
TJ	Operating Junction Temperature Range	unction Temperature Range -55 to 150		
	Thermal Resistance Junction-ambient¹(t≤10s)	40	°C/W	
$R_{ hetaJA}$	Thermal Resistance Junction-ambient <sup>1</sup>	65	°C/W	



### Electrical Characteristics (T<sub>C</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	40			V	
∆BVpss/∆TJ	BVDSS Temperature Coefficient	Reference to 25°C , I <sub>D</sub> =1mA		0.032		V/°C	
		V <sub>GS</sub> =10V , I <sub>D</sub> =7A		14.5	17		
RDS(ON)	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =4.5V , I <sub>D</sub> =6A		18	22	mΩ	
V <sub>G</sub> S(th)	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =250uA	1.0		2.5	V	
$\triangle V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient			-4.8		mV/°C	
	Drain-Source Leakage Current	V <sub>DS</sub> =32V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1		
IDSS		V <sub>DS</sub> =32V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C	2V , V <sub>GS</sub> =0V , T <sub>J</sub> =55°C		5	- uA	
Igss	Gate-Source Leakage Current	$V_{GS}$ = $\pm 20V$ , $V_{DS}$ = $0V$			±100	nA	
gfs	Forward Transconductance	V <sub>DS</sub> =5V , I <sub>D</sub> =7A		32		S	
R <sub>g</sub>	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		2.1		Ω	
Qg	Total Gate Charge (4.5V)			9.8			
Qgs	Gate-Source Charge	V <sub>DS</sub> =32V , V <sub>GS</sub> =4.5V , I <sub>D</sub> =7A		2.8		nC	
Qgd	Gate-Drain Charge			3.9			
T <sub>d(on)</sub>	Turn-On Delay Time			2.8			
Tr	Rise Time	V <sub>DD</sub> =20V , V <sub>GS</sub> =10V ,		40.4			
Td(off)	Turn-Off Delay Time	R <sub>G</sub> =3.3		22.8		ns	
T <sub>f</sub>	Fall Time	I <sub>D</sub> =7A		6.4			
Ciss	Input Capacitance			1013			
Coss	Output Capacitance	V <sub>DS</sub> =15V , V <sub>GS</sub> =0V , f=1MHz		107		рF	
Crss	Reverse Transfer Capacitance			76			
ls	Continuous Source Current <sup>1,5</sup>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			8.4	Α	
Isм	Pulsed Source Current <sup>2,5</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =1A , T <sub>J</sub> =25°C			50	Α	
Vsp	Diode Forward Voltage <sup>2</sup>				1	V	
trr	Reverse Recovery Time	IF=7A , dI/dt=100A/μs ,		10		nS	
Qrr	Reverse Recovery Charge	T <sub>J</sub> =25°C		3.3		nC	

#### Note:

- 1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width  $\leqq$  300us , duty cycle  $\leqq$  2%
- 3.The EAS data shows Max. rating . The test condition is  $V_{DD}$ =25V, $V_{GS}$ =10V,L=0.1mH, $I_{AS}$ =25A 45.The po.The data is theoretically the same as Iwer dissipation is limited by 150 $_{\rm o}$ °C and I junction temperature<sub>DM</sub> , in real applications , should be limited by total power dissipation.



### **Typical Characteristics**

# **40V N-Channel Enhancement Mode MOSFET**

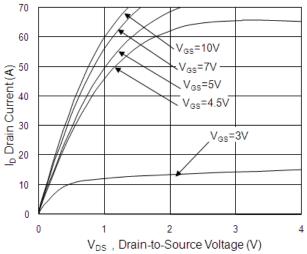


Fig.1 Typical Output Characteristics

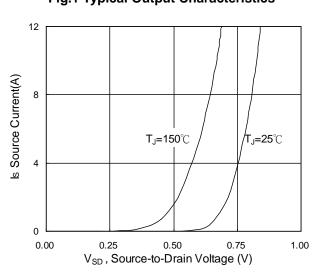


Fig.3 Forward Characteristics of Reverse

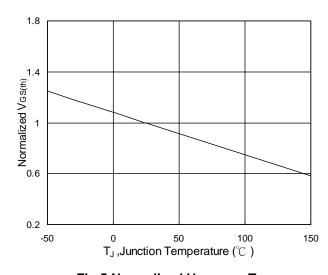


Fig.5 Normalized  $V_{\text{GS(th)}}$  vs.  $T_{\text{J}}$ 

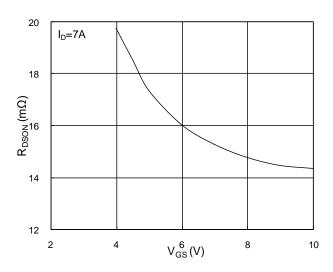


Fig.2 On-Resistance vs. G-S Voltage

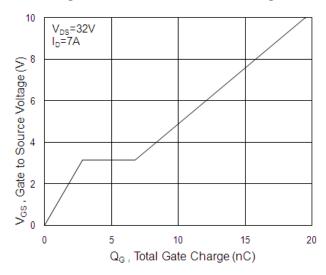


Fig.4 Gate-Charge Characteristics

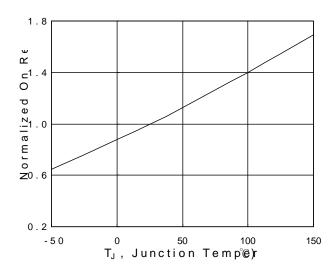
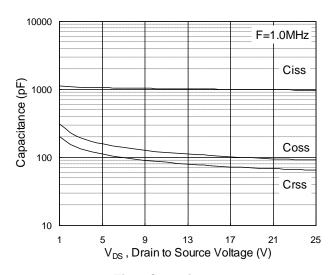


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>





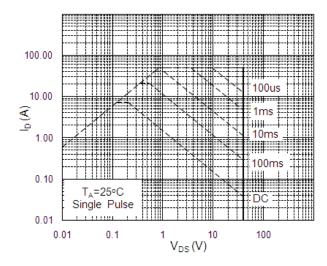


Fig.7 Capacitance

Fig.8 Safe Operating Area

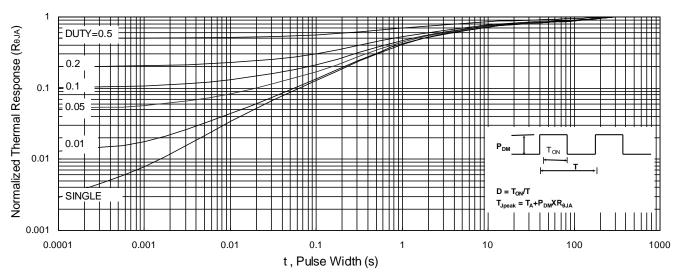


Fig.9 Normalized Maximum Transient Thermal Impedance

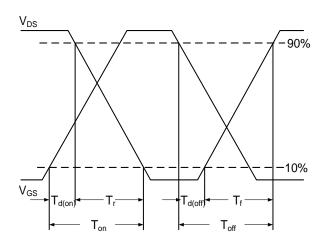


Fig.10 Switching Time Waveform

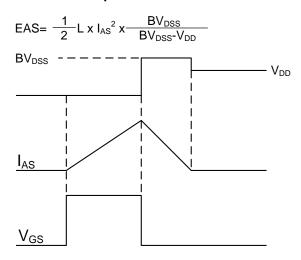
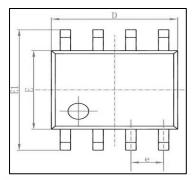
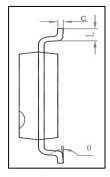


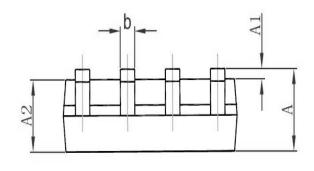
Fig.11 Unclamped Inductive Switching Waveform



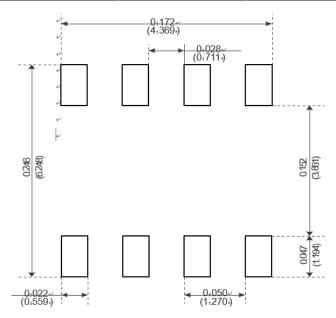
# Package Mechanical Data-SOP-8







Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
Α	1. 350	1. 750	0. 053	0.069
A1	0. 100	0. 250	0. 004	0. 010
A2	1. 350	1. 550	0. 053	0. 061
b	0. 330	0. 510	0. 013	0. 020
С	0. 170	0. 250	0.006	0. 010
D	4. 700	5. 100	0. 185	0. 200
E	3. 800	4. 000	0. 150	0. 157
E1	5. 800	6. 200	0. 228	0. 244
е	1. 270 (BSC)		0. 050 (BSC)	
L	0. 400	1. 270	0. 016	0. 050
θ	0°	8°	0°	8°



Recommended Minimum Pads



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